Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination LIN, JYH CHAIN	
10/805,048		
Examiner	Art Unit	
Hiep Nguyen	2816	

SEARCHED					
Subclass	Date	Examiner			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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